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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

*Applicant

Aaron O. Vanderpool, et al.

§ Group Art Unit:

2871

Serial No.:

10/789,851

Examiner:

Asok K. Sarkar

Filed:

February 26, 2004

Assignee:

Intel Corporation

For:

Implanting Carbon to Form P-Type

Source Drain Extensions

Atty. Dkt. No.:

ITL.1078US (P18386)

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

<u>INFORMATION DISCLOSURE STATEMENT</u>

Dear Sir:

Applicant submits the reference listed on the attached form PTO 1449 together with any required copies of such references.

This statement is being filed before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account 20-1504 (ITL.1078US).

Respectfully submitted,

Date: 7/22/05

Timothy No Trop, Registration No. 28,994

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Date of Deposit: July 22, 2005

I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as **first class mail** with sufficient postage on the date indicated above and is addressed to the Commissioner for Patents P.O. Box 1450, Alexandria, VA

Terri J. Benders

				ATTY DOCKET NO. SERIAL NO. ITL.1078US (P18386) 10/789,851				
O 1 PIRFORMATION DISCLOSURE CITATION				ITL.1078US (P18386) 10/789,851 APPLICANT(S):				
(a) se several sheets if necessary)				AARON O. VANDERPOOL AND MITCHELL C. TAYLOR				
JUL 2 5 2005			FILING DATE: February 26, 2004	GROUP ART UNIT: 2891				
U.S. PATENT DOCUMENTS								
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
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EXAMINER DATE CONSIDERED								
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								